IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

10/591193

Appl. No.	:	Unassigned	Confirmation No.	Unassigned
First Inventor	:	AZIMANE, Mohamed		
Filed	:	Concurrently		
TC/A.U.	:	Unassigned		
Examiner	:	Unassigned		

Docket No.	:	**US04 0145 US3**
Customer No.	:	24738

Title: DFT Technique for Stressing Self-Timed Semiconductor Memories to Detect Delay Faults

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

PRELIMINARY AMENDMENT

Sir:

Prior to calculation of the filing fee and examination please amend the above-identified application as follows:

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Claims begin on page 3 of this paper.

Remarks/Arguments begin on page 4 of this paper.